19-3071; Rev 1; 6/04

# EVALUATION KIT AVAILABLE Precision Transimpedance Logarithmic Amplifier with Over 5 Decades of Dynamic Range

# **General Description**

The MAX4206 logarithmic amplifier computes the log ratio of an input current relative to a reference current (externally or internally generated) and provides a corresponding voltage output with a default 0.25V/decade scale factor. The device operates from a single +2.7V to +11V supply or from dual  $\pm 2.7V$  to  $\pm 5.5V$  supplies and is capable of measuring five decades of input current across a 10nA to 1mA range.

The MAX4206's uncommitted op amp can be used for a variety of functions, including filtering noise, adding offset, and adding additional gain. A 0.5V reference is also included to generate an optional precision current reference using an external resistor, which adjusts the log intercept of the MAX4206. The output-offset voltage and the adjustable scale factor are also set using external resistors.

The MAX4206 is available in a space-saving 16-pin thin QFN package (4mm x 4mm x 0.8mm), and is specified for operation over the -40°C to  $+85^{\circ}$ C extended temperature range.

Photodiode Current Monitoring Portable Instrumentation Medical Instrumentation Analog Signal Processing

TOP VIEW (LEADS ON BOTTOM) REFIOUT CMVIN LOGIIN REFIIN 16 15 14 13 12 N.C 1.3 CMVOUT REFVOUT [11 REFISET 2 MAXIM 10 MAX4206 3 GND Vcc 4 9 N.C.  $V_{\text{EE}}$ 5 6 7 8 SCALE **OSADJ** .0GV2 0GV1 THIN QFN

# M/IXI/M

Features

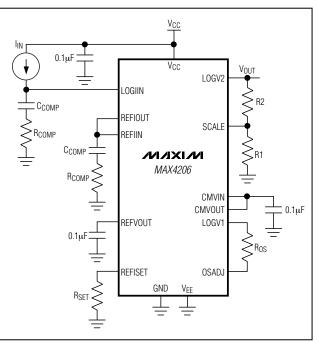
- + +2.7V to +11V Single-Supply Operation
- ±2.7V to ±5.5V Dual-Supply Operation
- 5 Decades of Dynamic Range (10nA to 1mA)
- Monotonic Over a 1nA to 1mA Range
- 0.25V/Decade Internally Trimmed Output Scale Factor
- Adjustable Output Scale Factor
- + Adjustable Output Offset Voltage
- Internal 10nA to 10µA Reference Current Source
- ♦ 0.5V Input Common-Mode Voltage
- Small 16-Pin Thin QFN Package (4mm x 4mm x 0.8mm)
- -40°C to +85°C Operating Temperature Range
- Evaluation Kit Available

# **Ordering Information**

PART	TEMP RANGE	PIN-PACKAGE
MAX4206ETE	-40°C to +85°C	16 Thin QFN-EP*

\*EP = Exposed paddle.

# **Typical Operating Circuit**



Maxim Integrated Products 1

For pricing, delivery, and ordering information, please contact Maxim/Dallas Direct! at 1-888-629-4642, or visit Maxim's website at www.maxim-ic.com.

# **Pin Configuration**

Applications

# **ABSOLUTE MAXIMUM RATINGS**

(All voltages referenced to GND, unless otherwise noted.)   V <sub>CC</sub> -0.3V to +12V   V <sub>EE</sub> -6V to +0.3V   Supply Voltage (V <sub>CC</sub> to V <sub>EE</sub> ) +12V   REFVOUT (V <sub>EE</sub> - 0.3V) to +3.0V   OSADJ, SCALE, REFISET (V <sub>EE</sub> - 0.3V) to +5.5V   REFIIN, LOGIIN (V <sub>EE</sub> - 0.3V) to V <sub>CMVIN</sub>	Continuous Current (REFIIN, LOGIIN)
REFIIN, LOGIIN(VEE - 0.3V) to VCMVIN	Storage Temperature Range65°C to +150°C
LOGV1, LOGV2, CMVOUT, REFIOUT(VFE - 0.3V) to (VCC + 0.3V)	Lead Temperature (soldering, 10s)+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

# DC ELECTRICAL CHARACTERISTICS—Single-Supply Operation

 $(V_{CC} = +5V, V_{EE} = GND = 0V, I_{REF} = 1\mu A, I_{LOG} = 10\mu A, LOGV2 = SCALE, LOGV1 = OSADJ, CMVIN = CMVOUT, R_{SET} > 1M\Omega, I_{CC} = 10\mu A, I_{CC} = 10\mu$  $T_A = -40^{\circ}$ C to +85°C. Typical values are at  $T_A = +25^{\circ}$ C, unless otherwise noted.) (Note 1)

PARAMETER	SYMBOL	COND	ITIONS	MIN	TYP	MAX	UNITS
Supply Voltage	V <sub>CC</sub>	(Note 2)		2.7		11.0	V
Supply Current	loo	$T_A = +25^{\circ}C$			3.9	5	mA
Supply Current	Icc	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$				7	ША
LOGIIN Current Range (Notes 3, 4)	lu oo	Minimum		10			nA
LOGIN Current hange (Notes 3, 4)	ILOG	Maximum				1	mA
REFIIN Current Range (Notes 3, 4)	IREF	Minimum		10			nA
neriin Cuiteni nange (Notes 3, 4)	IREF	Maximum				1	mA
Common-Mode Voltage	VCMVOUT			480	500	520	mV
Common-Mode Voltage Input Range	VCMVIN			0.5		1.0	V
Log Conformity Error	V <sub>LC</sub>	$I_{REF} = 10nA,$ $I_{LOG} = 10nA$ to 1mA,	T <sub>A</sub> = +25°C		±2	±5	mV
	VLC	K = 0.25V/decade (Note 4)	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$			±10	1110
Logarithmic Slope (Scale Factor)	К	$T_A = +25^{\circ}C$		237.5	250	262.5	mV/
Logantinnic Slope (Scale Factor)	IX.	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$	(Note 4)	231.25		268.75	decade
Logarithmic Slope (Scale Factor) Temperature Drift		$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$			80		µV/ decade/ °C
Input Offset Voltage	VIO	T <sub>A</sub> = +25°C, IV <sub>CMVIN</sub> IV <sub>CMVIN</sub> - V <sub>LOGIIN</sub> I	- V <sub>REFIIN</sub> I,		1	5	mV
Input Offset Voltage Temperature Drift	VIOS	IV <sub>CMVIN</sub> - V <sub>REFIIN</sub> I, IV <sub>C</sub>	cmvin - V <sub>LOGIIN</sub> I		6		µV/°C
Voltage Reference Output		$T_A = +25^{\circ}C$		1.218	1.238	1.258	v
	Vrefvout	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$ (	(Note 4)	1.195		1.275	v
Voltage Reference Output Current	IREFVOUT				1		mA
Current Reference Output Voltage	VREFISET	$T_A = +25^{\circ}C$		490	500	510	mV
	V KEFISEI	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$ (	(Note 4)	482		518	111V

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# DC ELECTRICAL CHARACTERISTICS—Single-Supply Operation (continued)

 $(V_{CC} = +5V, V_{EE} = GND = 0V, I_{REF} = 1\mu A, I_{LOG} = 10\mu A, LOGV2 = SCALE, LOGV1 = OSADJ, CMVIN = CMVOUT, R_{SET} > 1M\Omega, T_A = -40^{\circ}C$  to +85°C. Typical values are at T\_A = +25°C, unless otherwise noted.) (Note 1)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
LOGV2 BUFFER						
logut Offect ) (elterne		$T_A = +25^{\circ}C$		0.4	2	
Input Offset Voltage	V <sub>IO</sub>	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C \text{ (Note 4)}$			6	mV
Input Bias Current	Ι <sub>Β</sub>	(Note 4)		0.01	1	nA
Output Voltage Range	V <sub>OH</sub>	$R_L$ to GND = 2k $\Omega$		V <sub>CC</sub> - 0.2	V <sub>CC</sub> - 0.3	V
	Vol	$R_L$ to GND = $2k\Omega$	0.2	0.08		]
Output Chart Circuit Current	IOUT+	Sourcing		34		m (
Output Short-Circuit Current	IOUT-	Sinking		58		mA
Slew Rate	SR			12		V/µs
Unity-Gain Bandwidth	GBW			5		MHz

# AC ELECTRICAL CHARACTERISTICS—Single-Supply Operation

 $(V_{CC} = +5V, V_{EE} = GND = 0, I_{REF} = 1\mu A, I_{LOG} = 10\mu A, LOGV2 = SCALE, LOGV1 = OSADJ, CMVIN = CMVOUT, R_{SET} > 1M\Omega, T_A = +25^{\circ}C$ , unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	ТҮР	MAX	UNITS
LOGV2 Total Noise		0.1Hz to 10Hz, total output-referred noise, IREF = 10nA, ILOG = 100nA		17		μV <sub>RMS</sub>
LOGV2 Spot Noise Density		$f = 5kHz$ , $I_{REF} = 10nA$ , $I_{LOG} = 100nA$		0.8		µV/√Hz
REFVOUT Total Noise		1Hz to 10Hz, total output-referred noise		3.3		μV <sub>RMS</sub>
REFVOUT Spot Noise Density		f = 5kHz		266		nV/√Hz
REFISET Total Noise		1Hz to 10Hz, total output-referred noise		0.67		μV <sub>RMS</sub>
REFISET Spot Noise Density		f = 5kHz		23		nV/√Hz
Small-Signal Unity-Gain Bandwidth		$I_{REF}$ = 1μA, $I_{LOG}$ = 10μA, $R_{COMP}$ = 300Ω, $C_{COMP}$ = 32pF		1		MHz

# DC ELECTRICAL CHARACTERISTICS—Dual-Supply Operation

 $(V_{CC} = +5V, V_{EE} = -5V, GND = 0, I_{REF} = 1\mu A, I_{LOG} = 10\mu A, LOGV2 = SCALE, LOGV1 = OSADJ, CMVIN = CMVOUT, R_{SET} > 1M\Omega, T_A = -40^{\circ}C$  to +85°C. Typical values are at T\_A = +25°C, unless otherwise noted.) (Note 1)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Supply Voltage (Nate 2)	V <sub>CC</sub>		2.7		5.5	V
Supply Voltage (Note 2)	VEE		-2.7		-5.5	v
Supply Current	loo	$T_A = +25^{\circ}C$		5	6	mA
	lcc	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$			7.5	IIIA
LOGIIN Current Range (Notes 3, 4)	haa	Minimum	10			nA
LOGIN Current hange (Notes 3, 4)	ILOG	Maximum			1	mA
PEEIIN Current Pango (Notos 2, 4)	loce	Minimum	10			nA
REFIIN Current Range (Notes 3, 4)	IREF	Maximum			1	mA
Common-Mode Voltage	VCMVOUT		480	500	520	mV



# DC ELECTRICAL CHARACTERISTICS—Dual-Supply Operation (continued)

 $(V_{CC} = +5V, V_{EE} = -5V, GND = 0, I_{REF} = 1\mu A, I_{LOG} = 10\mu A, LOGV2 = SCALE, LOGV1 = OSADJ, CMVIN = CMVOUT, R_{SET} > 1M\Omega, T_A = -40^{\circ}C$  to +85°C. Typical values are at T\_A = +25°C, unless otherwise noted.) (Note 1)

PARAMETER	SYMBOL	COND	ITIONS	MIN	TYP	MAX	UNITS
Common-Mode Voltage Input Range	VCMVIN		_	0.5		1.0	V
Log Conformity Error	V <sub>LC</sub>	$I_{REF} = 10nA,$ $I_{LOG} = 10nA$ to 1mA,	T <sub>A</sub> = +25°C		±2	±5	mV
	VLC	K = 0.25V/decade (Note 4)	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$			±10	111 V
Logarithmic Slope (Scale Factor)	к	$T_A = +25^{\circ}C$		237.5	250	262.5	mV/
Eugantinnic Slope (Scale Factor)	IX.	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$		231.25		268.75	decade
Logarithmic Slope (Scale Factor) Temperature Drift		$T_{A} = -40^{\circ}C \text{ to } +85^{\circ}C$			80		µV/ decade °C
Input Offset Voltage	VIO	$T_A = +25^{\circ}C$ , $ V_{CMVIN} $ $ V_{CMVIN} - V_{LOGIIN} $	- V <sub>REFIIN</sub> I,		1	5	mV
Input Offset Voltage Temperature Drift	VIOS	IV <sub>CMVIN</sub> - V <sub>REFIIN</sub> I, IV <sub>C</sub>	CMVIN - VLOGIINI		6		µV/°C
Voltage Reference Output	VREFVOUT	$T_A = +25^{\circ}C$		1.218	1.238	1.258	V
Voltage Nelerence Output	VREEVOUT	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$ (	(Note 4)	1.195		1.275	v
Voltage Reference Output Current	IREFVOUT				1		mA
Current Reference Output	VREFISET	$T_A = +25^{\circ}C$		490	500	510	mV
Voltage	V REFISEI	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$ (	(Note 4)	482		518	1110
LOGV2 BUFFER	1	1		T			1
Input Offset Voltage	VIO	$T_A = +25^{\circ}C$			0.4	2	mV
	•10	$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$ (	(Note 4)			6	
Input Bias Current	IB	(Note 4)			0.01	1	nA
Output Voltage Range	V <sub>OH</sub>	$R_L$ to GND = 2k $\Omega$			V <sub>CC</sub> - 0.2	V <sub>CC</sub> - 0.3	v
Culput Voltage Hange	V <sub>OL</sub>	$R_L$ to GND = 2k $\Omega$		V <sub>EE</sub> + 0.2	V <sub>EE</sub> + 0.08		v
Output Chart Circuit Output	IOUT+	Sourcing			34		
Output Short-Circuit Current	IOUT-	Sinking			58		mA
Slew Rate	SR				12		V/µs
Unity-Gain Bandwidth	GBW				5		MHz

M/X/W

# AC ELECTRICAL CHARACTERISTICS—Dual-Supply Operation

 $(V_{CC} = +5V, V_{EE} = -5V, GND = 0, I_{REF} = 1\mu A, I_{LOG} = 10\mu A, LOGV2 = SCALE, LOGV1 = OSADJ, CMVIN = CMVOUT, R_{SET} > 1M\Omega, T_A = +25^{\circ}C$ , unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
LOGV2 Total Noise		0.1Hz to 10Hz, total output-referred noise, I <sub>REF</sub> = 10nA, I <sub>LOG</sub> = 100nA		17		μV <sub>RMS</sub>
LOGV2 Spot Noise Density		$f = 5kHz$ , $I_{REF} = 10nA$ , $I_{LOG} = 100nA$		0.8		µV/√Hz
REFVOUT Total Noise		1Hz to 10Hz, total output-referred noise		3.3		μV <sub>RMS</sub>
REFVOUT Spot Noise Density		f = 5kHz		266		nV/√Hz
REFISET Total Noise		1Hz to 10Hz, total output-referred noise		0.67		μV <sub>RMS</sub>
REFISET Spot Noise Density		f = 5kHz		23		nV/√Hz
Small-Signal Unity-Gain Bandwidth		$\label{eq:REF} \begin{array}{l} I_{REF} = 1 \mu \text{A}, \ I_{LOG} = 10 \mu \text{A}, \ R_{COMP} = 300 \Omega, \\ C_{COMP} = 32 p \text{F} \end{array}$		1		MHz

Note 1: All devices are 100% production tested at  $T_A = +25^{\circ}$ C. All temperature limits are guaranteed by design.

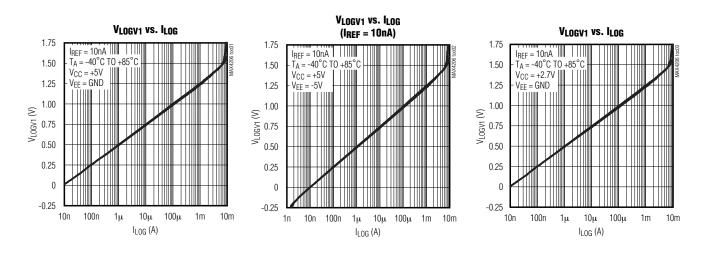
Note 2: Guaranteed and functionally verified.

Note 3: Log conformity error less than  $\pm$ 5mV with scale factor = 0.25V/decade.

Note 4: Guaranteed by design.

# **Typical Operating Characteristics**

 $(V_{CC} = +5V, V_{EE} = GND = 0V, I_{REF} = 1\mu A, I_{LOG} = 10\mu A, LOGV2 = SCALE, LOGV1 = OSADJ, CMVIN = CMVOUT, R_{SET} > 1M\Omega, T_A = +25^{\circ}C$ , unless otherwise noted.)

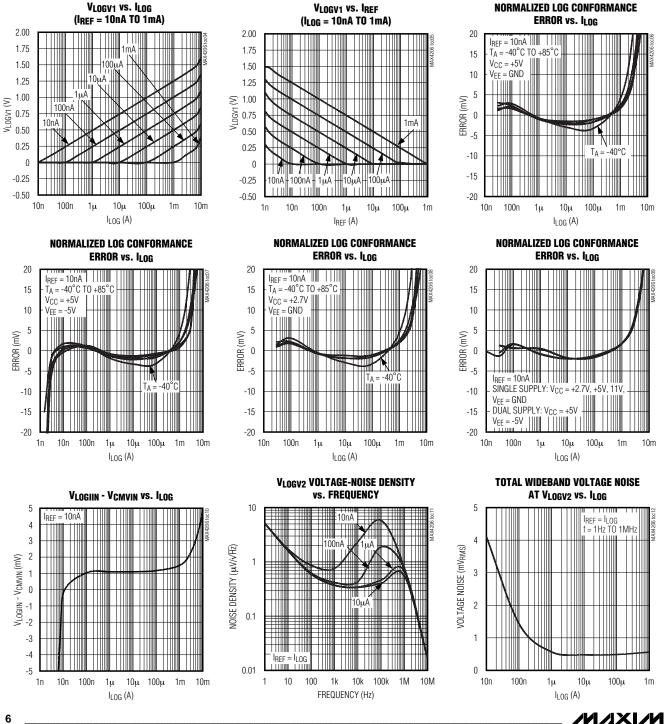


**MAX4206** 



# Typical Operating Characteristics (continued)

(V<sub>CC</sub> = +5V, V<sub>EE</sub> = GND = 0V, I<sub>REF</sub> = 1μA, I<sub>LOG</sub> = 10μA, LOGV2 = SCALE, LOGV1 = OSADJ, CMVIN = CMVOUT, R<sub>SET</sub> > 1MΩ,  $T_A = +25^{\circ}C$ , unless otherwise noted.)



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### ILOG PULSE RESPONSE **ILOG PULSE RESPONSE** (IREF = 100nA, (I<sub>REF</sub> = 100nA, $V_{CC} = 5V, V_{EE} = GND)$ $V_{CC} = 5V, V_{EE} = -5V)$ 1.0V 100µA TO 1mA 1.0V 100µA TO 1mA 0.75V 0.75V () 0.75V () 1.00V () 0.50V 0.75V 10µA TO 100µA 10µA TO 100µA VLOGV1 (V) 0.50V 0.50V 0.50V 1μΑ ΤΟ 10μΑ 1μΑ ΤΟ 10μΑ 0.25V 0.25V 0.25V 0.25V 100nA TO 1µA 100nA TO 1µA 0 0 20µs/div 20us/div **IREF PULSE RESPONSE** LOGARITHMIC SLOPE DISTRIBUTION $(I_{LOG} = 1mA)$ 30 1.0V 1µA TO 100nA 25 0.75V 20 0.75V 10µA TO 1µA VL0GV1 (V) COUNT (%) 0.50V 15 0.50V 100µA TO 10µA 10 0.25V 5 0.25V 1mA TO 100µA 0 0 255 240 245 250 260 SLOPE (mV/DECADE) 20µs/div **VREFVOUT DISTRIBUTION INPUT OFFSET VOLTAGE DISTRIBUTION** 25 16 $R_I = 100 k \Omega$ INPUT OFFSET VOLTAGE = VLOGIIN - VCMVIN 14 20 12 10 (%) 15 10 10 15 COUNT (%) 8 6 4 5 2 0 0

(V<sub>CC</sub> = +5V, V<sub>EE</sub> = GND = 0V, I<sub>REF</sub> = 1μA, I<sub>LOG</sub> = 10μA, LOGV2 = SCALE, LOGV1 = OSADJ, CMVIN = CMVOUT, R<sub>SET</sub> > 1MΩ,  $T_A = +25^{\circ}C$ , unless otherwise noted.)

**Typical Operating Characteristics (continued)** 

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1.232 1.234 1.236 1.238 1.240 1.242 1.244 -1.0 -0.5 0 0.5 1.0 1.5 2.0 2.5 3.0 VREFVOUT (V) INPUT OFFSET VOLTAGE (mV)

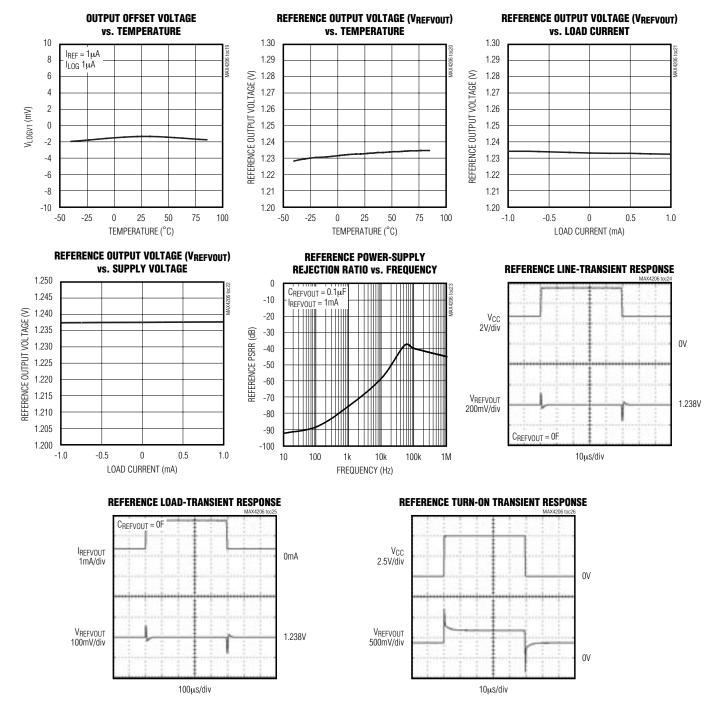
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**MAX4206** 

**MAX4206** 

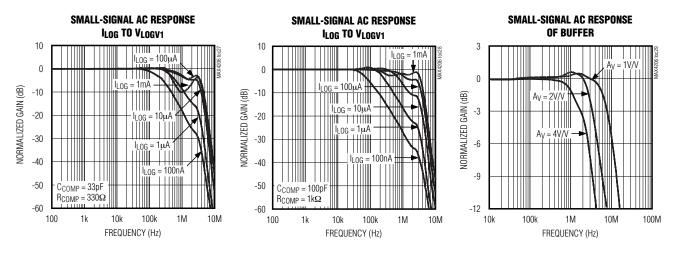
# **Typical Operating Characteristics (continued)**

 $(V_{CC} = +5V, V_{EE} = GND = 0V, I_{REF} = 1\mu A, I_{LOG} = 10\mu A, LOGV2 = SCALE, LOGV1 = OSADJ, CMVIN = CMVOUT, R_{SET} > 1M\Omega, T_A = +25^{\circ}C, unless otherwise noted.)$ 



# Typical Operating Characteristics (continued)

 $(V_{CC} = +5V, V_{EE} = GND = 0V, I_{REF} = 1\mu A, I_{LOG} = 10\mu A, LOGV2 = SCALE, LOGV1 = OSADJ, CMVIN = CMVOUT, R_{SET} > 1M\Omega, T_A = +25^{\circ}C$ , unless otherwise noted.)



# **Pin Description**

PIN	NAME	FUNCTION
1, 9	N.C.	No Connection. Not internally connected.
2	REFVOUT	1.238V Reference Voltage Output. Bypass REFVOUT to GND with a 0 to 1µF capacitor (optional).
3	GND	Ground
4	VEE	Negative Power Supply. Bypass $V_{EE}$ to GND with a 0.1µF capacitor.
5	LOGV1	Logarithmic Amplifier Voltage Output 1. The output scale factor of LOGV1 is 0.25V/decade.
6	OSADJ	Offset Adjust Input. When operating from a single power supply, current applied to OSADJ adjusts the output offset voltage (see the <i>Output Offset</i> section).
7	SCALE	Scale Factor Input. Adjust the output scale factor for LOGV2 using a resistive divider (see the <i>Scale Factor</i> section).
8	LOGV2	Logarithmic Amplifier Voltage Output 2. Adjust the output scale factor for LOGV2 using a resistive divider (see the <i>Scale Factor</i> section).
10	V <sub>CC</sub>	Positive Power Supply. Bypass $V_{CC}$ to GND with a 0.1µF capacitor.
11	REFISET	Current Reference Adjust Input. A resistor (R <sub>SET</sub> ), from REFISET to GND, adjusts the current at REFIOUT (see the <i>Adjusting the Logarithmic Intercept</i> section).
12	CMVOUT	0.5V Common-Mode Voltage Reference Output. Bypass CMVOUT to GND with a $0.1\mu$ F capacitor.
13	REFIOUT	Current Reference Output. The internal current reference output is available at REFIOUT.
14	REFIIN	Current Reference Input. Apply an external reference current at REFIIN. IREFIIN is the reference current used by the logarithmic amplifier when generating LOGV1.
15	LOGIIN	Current Input to Logarithmic Amplifier. LOGIIN is typically connected to a photodiode anode or other external current source.
16	CMVIN	Common-Mode Voltage Input. V <sub>CMVIN</sub> is the common-mode voltage for the input and reference amplifiers (see the <i>Common Mode</i> section).



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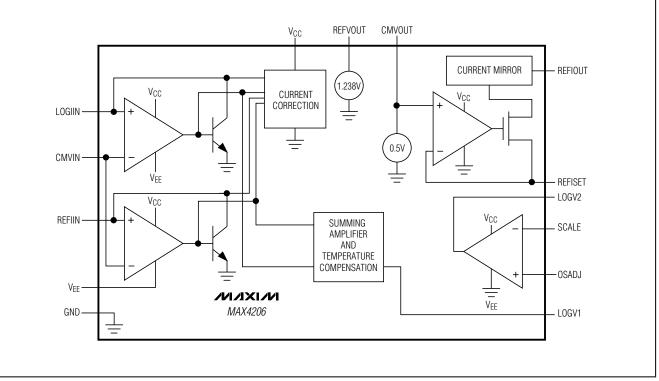


Figure 1. Functional Diagram

# **Detailed Description**

# Theory

Figure 2 shows a simplified model of a logarithmic amplifier. Two transistors convert the currents applied at LOGIIN and REFIIN to logarithmic voltages according to the following equation:

$$V_{BE} = \left(\frac{kT}{q}\right) \ln \left(\frac{l_C}{l_S}\right)$$

where:

 $V_{BE}$  = base-emitter voltage of a bipolar transistor

k = 1.381 x 10<sup>-23</sup> J/K

T = absolute temperature (K)

q = 1.602 x 10<sup>-19</sup> C

IC = collector current

Is = reverse saturation current

The logarithmic amplifier compares  $V_{BE1}$  to the reference voltage  $V_{BE2},$  which is a logarithmic voltage for a known reference current, IREF. The temperature dependence of temperatur

dencies of a logarithmic amplifier relate to the thermal voltage, (kT/q), and I<sub>S</sub>. Matched transistors eliminate the I<sub>S</sub> temperature dependence of the amplifier in the following manner:

$$\begin{split} &V_{OUT} = V_{BE1} - V_{BE2} \\ &= \left(\frac{kT}{q}\right) ln \left(\frac{l_{LOG}}{l_S}\right) - \left(\frac{kT}{q}\right) ln \left(\frac{l_{REF}}{l_S}\right) \\ &= \left(\frac{kT}{q}\right) \left[ln \left(\frac{l_{LOG}}{l_S}\right) - ln \left(\frac{l_{REF}}{l_S}\right)\right] \\ &= \left(\frac{kT}{q}\right) \left[ln \left(\frac{l_{LOG}}{l_{REF}}\right)\right] \\ &= \left(\frac{kT}{q}\right) (ln(10)) \left[log_{10} \left(\frac{l_{LOG}}{l_{REF}}\right)\right] \\ &= K \times log_{10} \left(\frac{l_{LOG}}{l_{REF}}\right) \end{split}$$
 (so

(see Figure 3)



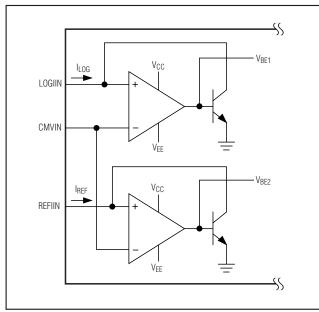


Figure 2. Simplified Model of a Logarithmic Amplifier

where:

K = scale factor (V/decade)

ILOG = the input current at LOGIIN

IREF = the reference current at REFIIN

The MAX4206 uses internal temperature compensation to virtually eliminate the effects of the thermal voltage, (kT/q), on the amplifier's scale factor, maintaining a constant slope over temperature.

# Definitions

### Transfer Function

The ideal logarithmic amplifier transfer function is:

$$V_{\text{IDEAL}} = K \times \log_{10} \left( \frac{I_{\text{LOG}}}{I_{\text{REF}}} \right)$$

Adjust K (see the *Scale Factor* section) to increase the transfer-function slope as illustrated in Figure 3. Adjust I<sub>REF</sub> using REFISET (see the *Adjusting the Logarithmic Intercept* section) to shift the logarithmic intercept to the left or right as illustrated in Figure 4.

# Log Conformity

Log conformity is the maximum deviation of the MAX4206's output from the best-fit straight line of the  $V_{LOGV1}$  versus log (I<sub>LOG</sub>/I<sub>REF</sub>) curve. It is expressed as a percent of the full-scale output or an output voltage.



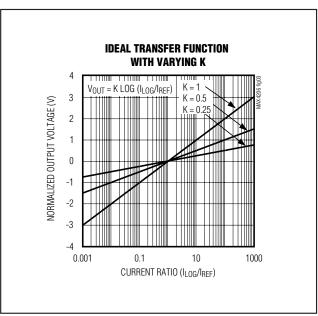


Figure 3. Ideal Transfer Function with Varying K

# Referred-to-Input and Referred-to-Output Errors

The log nature of the MAX4206 insures that any additive error at LOGV1 corresponds to multiplicative error at the input, regardless of input level.

### **Total Error**

Total error (TE) is defined as the deviation of the output voltage,  $V_{LOGV1}$ , from the ideal transfer function (see the *Transfer Function* section):

$$V_{LOGV1} = V_{IDEAL} \pm TE$$

Total error is a combination of the associated gain, input offset current, input bias current, output offset voltage, and transfer characteristic nonlinearity (log conformity) errors:

$$V_{LOGV2} = K(1 \pm \Delta K) \left[ log_{10} \left( \frac{l_{LOG} - l_{BIAS1}}{l_{REF} - l_{BIAS2}} \right) \pm 4 \left( \pm V_{LC} \pm V_{OSOUT} \right) \right]$$

where V<sub>LC</sub> and V<sub>OSOUT</sub> are the log conformity and output offset voltages, respectively. Output offset is defined as the offset occurring at the output of the MAX4206 when equal currents are presented to I<sub>LOG</sub> and I<sub>REF</sub>. Because the MAX4206 is configured with a gain of K = 0.25V/decade, a 4 should multiply the ( $\pm$ V<sub>LC</sub>  $\pm$ V<sub>OSOUT</sub>) term, if V<sub>LC</sub> and V<sub>OSOUT</sub> were derived from this default configuration.

 $I_{BIAS1}$  and  $I_{BIAS2}$  are currents in the order of 20pA, significantly smaller than  $I_{LOG}$  and  $I_{REF},$  and can therefore be eliminated:

$$V_{\text{LOGV2}} \cong K(1 \pm \Delta K) \left[ \log_{10} \left( \frac{|\text{LOG}|}{|\text{REF}|} \right) \pm 4 \left( \pm V_{\text{LC}} \pm V_{\text{OSOUT}} \right) \right]$$

Expanding this expression:

$$\begin{split} V_{\text{LOGV2}} &\cong \text{Klog}_{10} \left( \frac{l_{\text{LOG}}}{l_{\text{REF}}} \right) \pm \text{K}\Delta\text{Klog}_{10} \left( \frac{l_{\text{LOG}}}{l_{\text{REF}}} \right) \\ &\pm 4\text{K}(1 \pm \Delta\text{K}) \left( \pm V_{\text{LC}} \pm V_{\text{OSOUT}} \right) \end{split}$$

The first term of this expression is the ideal component of  $V_{LOGV1}$ . The remainder of the expression is the TE:

$$\mathsf{TE} \cong \pm \mathsf{K} \Delta \mathsf{K} \log_{10} \left( \frac{|\mathsf{LOG}|}{|\mathsf{REF}|} \right) \pm 4 \mathsf{K} (1 \pm \Delta \mathsf{K}) \left( \pm \mathsf{V}_{\mathsf{LC}} \pm \mathsf{V}_{\mathsf{OSOUT}} \right)$$

In the second term, one can generally remove the products relating to  $\Delta K$ , because  $\Delta K$  is generally much less than 1. Hence, a good approximation for TE is given by:

$$TE = \pm K \left[ \Delta K \log_{10} \left( \frac{I_{LOG}}{I_{REF}} \right) \pm 4 \left( \pm V_{LC} \pm V_{OSOUT} \right) \right]$$

As an example, consider the following situation:

Full-scale input = 5V

 $I_{LOG} = 100 \mu A$ 

 $I_{REF} = 100 nA$ 

K = 1  $\pm$ 5% V/decade (note that the uncommitted amplifier is configured for a gain of 4)

 $V_{LC} = \pm 5mV$  (obtained from the *Electrical Characteristics* table)

 $V_{OSOUT} = \pm 2mV (typ)$ 

 $T_A = +25^{\circ}C$ 

Substituting into the total error approximation,

As a worst case, one finds TE  $\approx \pm 178$ mV or  $\pm 3.6\%$  of full scale.

When expressed as a voltage, TE increases in proportion with an increase in gain as the contributing errors are defined at a specific gain. Calibration using a look-up table eliminates the effects of gain and output offset errors, leaving conformity error as the only factor con-

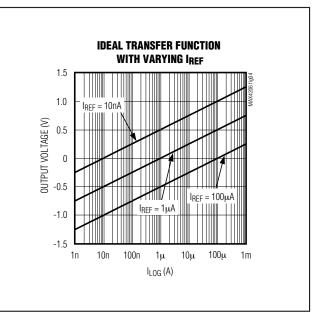


Figure 4. Ideal Transfer Function with Varying IREF

tributing to total error. For further accuracy, consider temperature monitoring as part of the calibration process.

# **Applications Information**

# Input Current Range

Five decades of input current across a 10nA to 1mA range are acceptable for I<sub>LOG</sub> and I<sub>REF</sub>. The effects of leakage currents increase as I<sub>LOG</sub> and I<sub>REF</sub> fall below 10nA. Bandwidth decreases at low I<sub>LOG</sub> values (see the *Frequency Response and Noise Considerations* section). As I<sub>LOG</sub> and I<sub>REF</sub> increase to 1mA or higher, transistors become less logarithmic in nature. The MAX4206 incorporates leakage current compensation and high-current correction circuits to compensate for these errors.

# **Frequency Compensation**

The MAX4206's frequency response is a function of the input current magnitude and the selected compensation network at LOGIIN and REFIIN. The compensation network comprised of C<sub>COMP</sub> and R<sub>COMP</sub> ensures stability over the specified range of input currents by introducing an additional pole/zero to the system. For the typical application, select C<sub>COMP</sub> = 100pF and R<sub>COMP</sub> = 100 $\Omega$ . Where high bandwidth at low current is required, C<sub>COMP</sub> = 32pF and R<sub>COMP</sub> = 330 $\Omega$  are suitable compensation values.



# Frequency Response and Noise Considerations

The MAX4206 bandwidth is proportional to the magnitude of the I<sub>REF</sub> and I<sub>LOG</sub> currents, whereas the noise is inversely proportional to I<sub>REF</sub> and I<sub>LOG</sub> currents.

# Common Mode

A common-mode input voltage, VCMVOUT, of 0.5V is available at CMVOUT and can be used to bias the logging and reference amplifier inputs by connecting CMVOUT to CMVIN. An external voltage between 0.5V and 1V can be applied to CMVIN to bias the logging and reference transistor collectors and to optimize the performance required for both single- and dual-supply operation.

### Adjusting the Logarithmic Intercept

Adjust the logarithmic intercept by changing the reference current, IREF. A resistor from REFISET to GND (see Figures 5 and 6) adjusts the reference current, according to the following equation:

$$R_{SET} = \frac{V_{REFISET}}{10 \times I_{REF}}$$

where V<sub>REFISET</sub> is 0.5V. Select R<sub>SET</sub> between  $5k\Omega$  and  $5M\Omega$ . REFIOUT current range is 10nA to 10µA only.

### **Single-Supply Operation**

When operating from a single +2.7V to +11V supply,  $I_{LOG}$  must be greater than  $I_{REF}$ , resulting in a positive slope of the log output voltages, LOGV1 and LOGV2. Bias the log and reference amplifiers by connecting CMVOUT to CMVIN or connecting an external voltage reference between 0.5V and 1V to CMVIN. For single-supply operation, connect V<sub>EE</sub> to GND.

### **Output Offset**

Select R<sub>OS</sub> and I<sub>OS</sub> to adjust the output offset voltage (see Figure 5). The magnitude of the offset voltage is given by:

$$VOS = ROS \times IOSADJ$$

### Scale Factor

The scale factor, K, is the slope of the logarithmic output. For the LOGV1 amplifier, K = 0.25V/decade. When operating in a single-supply configuration, adjust the overall scale factor for the MAX4206 using the uncommitted LOGV2 amplifier and the following equation, which refers to Figure 5:

$$R2 = R1\left(\frac{K}{0.25} - 1\right)$$

Select R1 between  $1k\Omega$  and  $100k\Omega$ , with an ideal value of  $10k\Omega$ . The noninverting amplifier ensures that the overall scale factor is greater than or equal to 0.25V/decade for single-supply operation.

Design Example

Desired:

Single-Supply Operation

Logarithmic intercept: 100nA

Overall scale factor = 1V/decade

Because there is no offset current applied to the circuit ( $R_{OS} = 0\Omega$ ), the reference current, I<sub>REF</sub>, equals the log intercept of 100µA. Therefore,

$$R_{SET} = \frac{0.5V}{10 \times 100 \text{nA}} = 500 \text{k}\Omega$$

Select  $R_1 = 10k\Omega$ :

$$R2 = 10k\Omega\left(\frac{1V/V}{0.25} - 1\right) = 30k\Omega$$

### **Dual-Supply Operation**

When operating from dual ±2.7 to ±5.5V supplies, it is not required that I<sub>LOG</sub> be greater than I<sub>REF</sub>. A positive output voltage results at LOGV1 when I<sub>LOG</sub> exceeds I<sub>REF</sub>. A negative output voltage results at LOGV1 when I<sub>LOG</sub> is less than I<sub>REF</sub>. Bias the log and reference amplifiers by connecting CMVOUT to CMVIN or connect an external 0.5V to 1V reference to CMVIN. For dual-supply operation with CMVIN < 0.5V, refer to the MAX4207 data sheet.

### **Output Offset**

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The uncommitted amplifier in the inverting configuration utilized by the MAX4206 facilitates large output-offset voltage adjustments when operated with dual supplies. The magnitude of the offset voltage is given by the following equation:

$$V_{OS} = V_{OSADJ} \left( 1 + \frac{R_2}{R_1} \right)$$

A resistive divider between REFVOUT, OSADJ, and GND can be used to adjust  $V_{\mbox{OSADJ}}$  (see Figure 6).

$$V_{OSADJ} = V_{REFOUT} \left( \frac{R_4}{R_3 + R_4} \right)$$

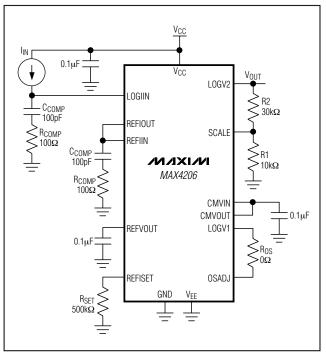


Figure 5. Single-Supply Typical Operating Circuit

### Scale Factor

The scale factor, K, is the slope of the logarithmic output. For the LOGV1 amplifier, K = 0.25V/decade. When operating from dual supplies, adjust the overall scale factor for the MAX4206 using the uncommitted LOGV2 amplifier and the following equation, which refers to Figure 6:

$$R_2 = R_1 \left(\frac{K}{0.25}\right)$$

Select R<sub>2</sub> between  $1k\Omega$  and  $100k\Omega$ .

### Design Example

Desired:

**Dual-Supply Operation** 

Logarithmic intercept: 1µA

Overall scale factor = 1V/decade

$$R_{SET} = \frac{0.5V}{10 \times 1\mu A} = 50k\Omega$$

Select  $R_1 = 10k\Omega$ :

$$R2 = 10k\Omega \times \left(\frac{1V/decade}{0.25}\right) = 40k\Omega$$

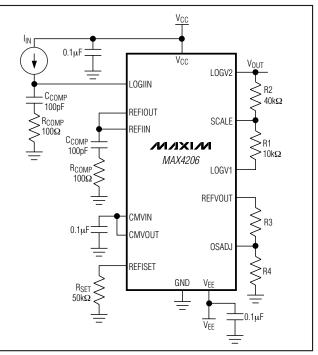


Figure 6. Dual-Supply Typical Operating Circuit

### Measuring Optical Absorbance

A photodiode provides a convenient means of measuring optical power, as diode current is proportional to the incident optical power. Measure absolute optical power using a single photodiode connected at LOGIIN, with the MAX4206's internal current reference driving REFIIN. Alternatively, connect a photodiode to each of the MAX4206's logging inputs, LOGIIN and REFIIN, to measure relative optical power (Figure 7).

In absorbance measurement instrumentation, a reference light source is split into two paths. The unfiltered path is incident upon the photodiode of the reference channel, REFIIN. The other path passes through a sample of interest, with the resulting filtered light incident on the photodiode of the second channel, LOGIIN. The MAX4206 outputs provide voltages proportional to the log ratio of the two optical powers—an indicator of the optical absorbance of the sample.

In wavelength-locking applications, often found in fiberoptic communication modules, two photodiode currents provide a means of determining whether a given optical channel is tuned to the desired optical frequency. In this application, two bandpass optical filters with overlapping "skirts" precede each photodiode. With proper filter selection, the MAX4206 output can vary monotonically (ideally linearly) with optical frequency.



### **Photodiode Current Monitoring**

Figure 8 shows the MAX4206 in a single-supply, opticalpower measurement circuit, common in fiberoptic applications. The MAX4007 current monitor converts the sensed APD current to an output current that drives the MAX4206 LOGIIN input (APD current is scaled by 0.1). The MAX4007 also buffers the high-voltage APD voltages from the lower MAX4206 voltages. The MAX4206's internal current reference sources 10nA (RSET = 5M $\Omega$ ) to the REFIIN input. This configuration sets the logarithmic intercept to 10nA, corresponding to an APD current of 100nA. The unity-gain configuration of the output buffer maintains the 0.25V/decade gain present at the LOGV1 output.

# **Capacitive Loads**

The MAX4206 drives capacitive loads of up to 50pF. Reactive loads decrease phase margin and can produce excessive ringing and oscillation. Use an isolation resistor in series with LOGV1 or LOGV2 to reduce the effect of large capacitive loads. Recall that the combination of the capacitive load and the small isolation resistor limits AC performance.

# **Power Dissipation**

The LOGV1 and LOGV2 amplifiers are capable of sourcing or sinking in excess of 30mA. Ensure that the continuous power dissipation rating for the MAX4206 is not exceeded.

### **TQFN Package**

The 16-lead thin QFN package has an exposed paddle that provides a heat-removal path, as well as excellent electrical grounding to the PC board. The MAX4206's exposed pad is internally connected to  $V_{EE}$ , and can either be connected to the PC board  $V_{EE}$  plane or left unconnected. Ensure that only  $V_{EE}$  traces are routed under the exposed paddle.

# Layout and Bypassing

Bypass V<sub>CC</sub> and V<sub>EE</sub> to GND with ceramic  $0.1\mu$ F capacitors. Place the capacitors as close to the device as possible. Bypass REFVOUT and/or CMVOUT to GND with a  $0.1\mu$ F ceramic capacitor for increased

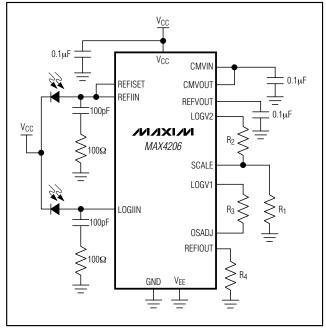


Figure 7. Measuring Optical Absorbance

noise immunity and a clean reference current. For lowcurrent operation, it is recommended to use metal guard rings around LOGIIN, REFIIN, and REFISET. Connect this guard ring to CMVOUT.

### **Evaluation Kit**

An evaluation kit is available for the MAX4206. The kit is flexible and can be configured for either single-supply or dual-supply operation. The scale factor and reference current are selectable. Refer to the MAX4206 Evaluation Kit data sheet for more information.

# \_Chip Information

TRANSISTOR COUNT: 754 PROCESS: BICMOS



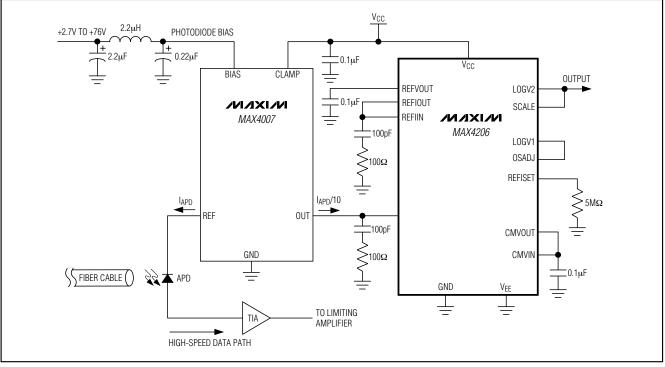
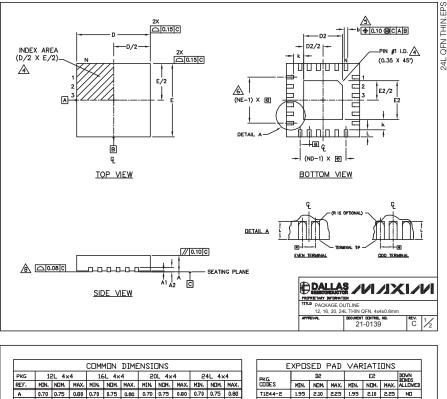


Figure 8. Logarithmic Current-Sensing Amplifier with Sourcing Input

# Package Information

(The package drawing(s) in this data sheet may not reflect the most current specifications. For the latest package outline information, go to **www.maxim-ic.com/packages**.)



# **MAX4206**

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REF.	MIN.	NDM.	MAX.	MIN.	NDM.	MAX.	MIN.	NDM.	MAX.	MIN,	NDM.	MAX.		CODES	MIN.	NDM.	MAX.	MIN.	NDM.	MAX.	ALLOVE
A	0.70	0.75	0.80	0.70	0.75	0.80	0.70	0.75	0.80	0.70	0.75	0.80		T1244-2	1.95	2.10	2.25	1.95	2.10	2.25	ND
A1	0.0	20.0	0.05	0.0	0.02	0.05	0.0	20.0	0.05	0.0	0.02	0.05		T1244-3	1.95	2.10	2,25	1.95	2.10	2.25	YES
A2	0	).20 RE	F	0	.20 RE	F	0	.20 RE	F	0	20 RE	F		T1244-4	1.95	2.10	2.25	1.95	2.10	2.25	ND
b	0.25	0.30	0.35	0.25	0.30	0.35	0.20	0.25	0.30	0.18	0.23	0.30		T1644-2	1.95	2.10	2,25	1.95	2.10	2,25	ND
D	3.90	4.00	4.10	3.90	4.00	4.10	3.90	4.00	4.10	3.90	4.00	4.10		T1644-3	1.95	2.10	2.25	1.95	2.10	2.25	YES
E	3.90	4.00	4.10	3.90	4.00	4.10	3.90	4.00	4.10	3.90	4.00	4.10		T1644-4	1.95	2.10	2,25	1.95	2.10	2.25	ND
e		0.80 BS	SC.	0	65 DS	c.	0	.50 BS	c.	0	.50 BS	SC.		T2044-1	1.95	2.10	2.25	1.95	2.10	2.25	ND
ĸ	0.25	-	-	0.25	-	-	0.25	-	-	0.25	-	-		T2044-2	1.95	2.10	2,25	1.95	2.10	2,25	YES
L	0.45	0.55	0.65	0.45	0.55	0.65	0.45	0.55	0.65	0.30	0.40	0.50		T2044-3	1.95	2.10	2.25	1.95	2.10	2.25	ND
N		12			16			20			24			T2444-1	2.45	2.60	2.63	2.45	2.60	2.63	ND
ND		3			4			5			6			T2444-2	1.95	2.10	2.25	1.95	2.10	2.25	YES
NE		3			4			5			6			T2444-3	2.45	2.60	2.63	2.45	2.60	2.63	YES
ledec Var.		WGGB			WGGC		· ۱	WGGD-	1		WGGD-	-2		T2444-4	2.45	2.60	2.63	2.45	2.60	2.63	ND
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